

<b>Notice of References Cited</b>	Application/Control No. 10/708,996		Applicant(s)/Patent Under Reexamination SUN ET AL.	
	Examiner Rodney B. White		Art Unit 3636	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,738,411	04-1998	Sutton et al.	297/378.12
*	B	US-5,826,942 A	10-1998	Sutton et al.	297/378.12
*	C	US-5,954,398 A	09-1999	Namba et al.	297/378.12X
*	D	US-6,113,187 A	09-2000	Sugiyama et al.	297/15X
*	E	US-6,183,033 B1	02-2001	Arai et al.	296/65.09
*	F	US-6,196,613 B1	03-2001	Arai, Tomiji	296/65.13
*	G	US-6,568,756 B2	05-2003	Sugimoto et al.	297/334X
*	H	US-6,598,926 B1	07-2003	Price et al.	296/65.09
*	I	US-2004/0150243 A1	08-2004	Epaud et al.	296/65.09
*	J	US-6,817,646 B2	11-2004	Kikuchi et al.	296/65.05
*	K	US-6,908,155 B1	06-2005	Wieclawski, Stanislaw Andrzej	297/378.12X
*	L	US-6,997,500 B2	02-2006	Horsford et al.	296/65.09X
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	W	
	X	

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